

<b>Notice of References Cited</b>	Application/Control No. 10/711,269	Applicant(s)/Patent Under Reexamination DEWANJEE, PIJUSH K.	
	Examiner David Buttner	Art Unit 1712	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0111541	05-2006	Dewanjee, Pijush K.	528/064
*	B	US-6,787,626	09-2004	Dewanjee, Pijush K.	528/64
*	C	US-6,762,273	07-2004	Dewanjee, Pijush K.	528/64
*	D	US-2003/0203771	10-2003	Rosenberg et al.	473/371
*	E	US-2003/0171166	09-2003	Cavallaro et al.	473/371
*	F	US-2003/0064826	04-2003	Voorheis et al.	473/367
*	G	US-6,486,261	11-2002	Wu et al.	525/332.6
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.